

<b>Notice of References Cited</b>	Application/Control No. 10/716,404		Applicant(s)/Patent Under Reexamination MIKAWA, TAKUMA	
	Examiner HELEN SHIBRU		Art Unit 2621	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2008/0065780	03-2008	Iwata et al.	709/231
*	B	US-7,209,643	04-2007	Sato et al.	386/95
*	C	US-2006/0265421	11-2006	Ranasinghe et al.	707/104.1
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	K	US-			
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	N					
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#### NON-PATENT DOCUMENTS

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